## IN THE CLAIMS:

Please amend claims 1-2, 5-8, 15, 19, 21, 23-24, 27-33 as follows:

1. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN; and including barrier layers sandwiching said at least one quantum well; and

confinement layers sandwiching said active region.

- 2. (Once amended) The VCSEL of claim 1 wherein said barrier layers are comprised of GaAsN.
- 5. (Once amended) The VCSEL of claim 1 wherein said at least one quantum well further comprises >1% N.
- 6. (*Once amended*) The VCSEL of claim 1 wherein said at least one quantum well is up to and including 50Å in thickness.
- 7. (Once amended) The VCSEL of claim 5 wherein said at least one quantum well is up to and including 50Å in thickness.
- 8. (Once amended) The VCSEL of claim 1 wherein said barrier layers are comprised of GaAsN.
- 15. (Once amended) The VCSEL of claim 14 wherein said barrier layers are comprised of GaAsN.
- 19. (Once amended) The VCSEL of claim 1 wherein said at least one quantum well further comprises >1% N.

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21. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN; and including AlGaAs barrier layers sandwiching said at least one quantum well; and

confinement layers sandwiching said active region.

- 23. (Once amended) The VCSEL of claim 21 wherein said at least one quantum well is up to and including 50Å in thickness.
- 24. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN; and including barrier layers sandwiching said at least one quantum well; and

AlGaAs confinement layers sandwiching said active region.

- 27. (Once amended) The VCSEL of claim 24 wherein said at least one quantum well is up to and including 50Å in thickness.
- 28. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN; and including AlGaAs barrier layers sandwiching said at least one quantum well; and

AlGaAs confinement layers sandwiching said active region.

29. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised ofe InGaAsN; and including InGaAs barrier layers sandwiching said at least one quantum well; and

AlGaAs confinement layers sandwiching said active region.

30. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN and including GaAsN barrier layers sandwiching said at least one quantum well; and

GaAsN confinement layers sandwiching said active region.

31. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN and including AlGaAs barrier layers sandwiching said at least one quantum well; and

AlGaAs confinement layers sandwiching said active region.

32. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN and including GaAsN barrier layers sandwiching said at least one quantum well; and

AlGaAs confinement layers sandwiching said active region.

33. (Once amended) A vertical cavity surface emitting laser (VCSEL), comprising:

an active region further comprising at least one quantum well having a well depth of at least 40 meV and comprised of InGaAsN and including AlGaAs barrier layers sandwiching said at least one quantum well; and

GaAsN confinement layers sandwiching said active region.

## **Un-amended Claims remain in the application as follows:**

- 3. (*Not amended*) The VCSEL of claim 1 wherein said confinement layers are comprised of AlGaAs.
- 4. (*Not amended*) The VCSEL of claim 1 wherein said confinement layers are comprised of AlGaAs.
- 9. (*Not amended*) The VCSEL of claim 5 wherein said confinement layers are comprised of AlGaAs.
- 10. (*Not amended*) The VCSEL of claim 7 wherein said barrier layers are comprised of AlGaAs.
- 11. (*Not amended*) The VCSEL of claim 8 wherein said confinement layers are comprised of AlGaAs.
- 12. (*Not amended*) The VCSEL of claim 5 wherein said barrier layers are comprised of AlGaAs.
- 14. (*Not amended*) The VCSEL of claim 1 wherein said at least one quantum well is further comprised of Sb.

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- 16. (*Not amended*) The VCSEL of claim 14 wherein said confinement layers are comprised of AlGaAs.
- 17 (Not amended) The VCSEL of claim 16 wherein said barrier layers are comprised of AlGaAs.
- 18. (*Not amended*) The VCSEL of claim 15 wherein said confinement layers are comprised of AlGaAs.
- 19. (*Not amended*) The VCSEL of claim 14 wherein said barrier layers are comprised of AlGaAs.
- 20. (*Not amended*) The VCSEL of claim 19 wherein said confinement layers are comprised of AlGaAs.
- 22. (*Not amended*) The VCSEL of claim 21 wherein said confinement layers are comprised of AlGaAs.
- 25. (*Not amended*) The VCSEL of claim 24 wherein said barrier layers are comprised of AlGaAs.
- 26. (*Not amended*) The VCSEL of claim 24 wherein said barrier layers are comprised of InGaAsN.